MOS IC

Туре	Ordering code	Package	
SDA 2010	Q67120-C74	DIP 40	

#### **Features**

- 8-bit CPU, ROM, RAM, I/O in a DIP 40 package
- 4 analog outputs with 6 bit resolution
- 30 digital I/O lines two serial interfaces two 8-bit interfaces two 4-bit interfaces two test inputs
- 2 Kbyte ROM
- 64 byte RAM
- 7.5 μs cycle time at 4 MHz crystal frequency 1 or 2 cycles per instruction
- Zero passage detector
- Interface for modulated digital signal
- Interval timer/counter
- 5 V supply voltage
- SAB 8048 instruction subset

## Circuit description<sup>1)</sup>

The SDA 2010 stresses application-specific control functions surpassing the former purely numeric computation performance. As a result, the use of additional hardware could be reduced and software operations have been simplified, optimizing cost savings during the developmental and production stages. Although the SDA 2010 was designed for electronic entertainment devices, it is equally suitable for mass-produced applications requiring highly economic components.

The SDA 2010 includes a 2 Kbyte program memory (ROM), a 64 byte data memory (RAM) and four 6-bit D/A converters. The 30 digital I/O lines are comprised of two 4 and 8-bit ports each, two test inputs and 2 serial interfaces consisting of one data and one clock line each. Test input T0 processes signals modulated with approx. 30 kHz and is equipped with a digital demodulator, which derives the envelope curve from the modulated digital signal. Since the digital demodulator forwards an unmodulated signal without changing it, test input T0 can also function as a normal digital input during operations with standard H/L levels. Test input T1 includes a zero passage detector and can also serve as a normal digital input. The SDA 2010 is equipped with its own oscillator and timer/counter.

<sup>1)</sup> Detailed description is available upon request

The instruction set includes 65 instructions (1-2 bytes), which can be processed in max. 2 cycles. Numerical problems can be processed in either binary or BCD arithmetic modes. The large number of available bit-handling instructions increases the efficiency of the controller functions.

Program development and system testing for the SDA 2010 are carried out on the SME development system in conjunction with the SDA 2010 emulator board EMB U2. The EMB U2 emulator consists of one 2 K EPROM (SAB 2716) as well as a 40 pin socket which is used to insert an SAB 8035 type microprocessor or an ICE 48 plug. In addition, the EMB U2 contains all the necessary hardware to simulate the four analog outputs and the serial and parallel interfaces of the SDA 2010. A 40 wire cable is used to connect the U2 emulator with the user system.

A version without the ROM (SDA 3010) is available for in-house software development on an SME system.

## Maximum ratings

Maximum ramiga		0 F to 7	l v
Supply voltage range Voltage between any pin and ground Total power dissipation Storage temperature range	$egin{array}{c} V_{ ext{CC}} \ V \ P_{ ext{tot}} \ T_{ ext{stg}} \ \end{array}$	-0.5 to 7 -0.5 to 7 1 -40 to 125	, C M A

## Operating range

Operating range	.,	5 ± 10%	V
Supply voltage Ambient temperature	V <sub>CC</sub> T <sub>A</sub>	0 to 70	°c

## DC characteristics

 $T_A = 0$  °C to 70 °C,  $V_{CC} = 5$  V  $\pm 10\%$ ;  $V_{SS} = 0$  V

			min	max	
L input voltage	(Ports, SS0, SS1, RESET, T0, T1, X1)	V <sub>i1</sub>	-0.5	0.8	v
H input voltage	(Ports, SS0, SS1)	ViH	2.0	V <sub>CC</sub>	ľv
	$V_{\rm CC} = 5.0 \text{ V} \pm 10\%$	*1H	2.0	*cc	*
H input voltage	(Ports, SS0, SS1)	$V_{iH1}$	2.4	Vcc	v
	$V_{\rm CC} = 6.0 \text{ V} \pm 0.5 \text{ V}$	-1111		*CC	*
H input voltage	(RESET, X1, T0, T1)	$V_{iH2}$	3.5	<sub>V</sub>	v
L output voltage	(Ports, ALE)	V <sub>qL</sub>	1 3.3	V <sub>CC</sub> 0.45	ľ
	$I_{\rm ol} = 1.6 \mathrm{mA}$	dr		0.45	\ <b>V</b>
L output voltage	(\$50, SS1, SCP0, SCP1)	$V_{qL1}$		0.45	V
	$I_{aL} = 4 \text{ mA}$	*qL1	J	0.45	<b>v</b>
L output voltage	(A00-A03)	$V_{qL2}$		0.45	1,,
_	$I_{\rm gL} = 4 \text{ mA}$	Vq L2		0.45	٧
H output voltage	(Ports, ALE)	V .	2.4		1.,
	I <sub>αH</sub> = 50 μA	$V_{qH}$	2.4		٧
H output voltage	(SS0, SS1, SCP1)	$V_{aH1}$	2.4		١.,
	I <sub>n H</sub> = 150 μA	♥q H1	2.4		V
H output voltage	(A00-A03)	$V_{qH2}$	V <sub>CC</sub> -0.45		
· -	$I_{\text{oH}} = 4 \text{ mA}$	¥q H2	VCC-0.45		V
H input current	(TO, T1)	7	1 1	40	1.
•	$V_{\rm IH} = V_{\rm CC}$	$I_{iH}$		10	μA
L input current	(Ports, SS0, SS1)	_7	100	0.40	1 .
	$V_{ij} = 0.45 \text{ V}$	$-I_{iL}$	30	340	μΑ
Input voltage at T1	(C <sub>i</sub> = 1 μF) (peak-to-peak)	V			1
Zero passage detector	(-) p. / (pour to-peak)	<i>V</i> <sub>T1</sub>	1	3	V
current consumption		,	1 1	00	
		$I_{\sf CC}$	1 1	80	mA

### **AC** characteristics

$T_A = 0$ °C to 70 °C, $V_{CC} = 5 \text{ V} \pm 10\%$ ; $V_{SS} = 0 \text{ V}$		min	max	
Cycle time	tc	10	50	
3 MHz crystal; = 10 μs	••	.0	1 30	μs
ALE pulse width	t <sub>ALE</sub>	1.3	i	μs
$t_{\rm C} = 10~\mu{\rm s}$ Oscillator frequency deviation $f = 2.5~{\rm MHz}, R = 15~{\rm k}\Omega$	$\Delta t_{\rm OSC}$	-20	+20	%
Length of an unmodulated signal at the T0 test input  3 MHz crystal	$t_{MTO}$	60	_	μs
Frequency of a modulated signal at the T0 test input  3 MHz crystal	$f_{TR}$	30	35	kHz
Frequency range of the zero passage detector (input T1)	<i>t</i> <sub>T1</sub>	0.03	1	kHz

# Pin description

Pin	Symbol	Function
40	V <sub>CC</sub>	+ 5 V
20	V <sub>SS</sub>	GND 0 V
21, 22	X1, X2	Connection for crystal or similar
10–17	P0 0-7	Quasi-bidirectional 8-bit port
24-31	P1 0-7	Quasi-bidirectional 8-bit port
32-35	P2 0-3	Quasi-bidirectional 4-bit port
7–4	P3 0-3	Quasi-bidirectional 4-bit port
38, 39, 1, 2	A00-A0-A3	4 analog outputs. The analog values are output as rectangular signals with a frequency of approx. 2 kHz, during which the duty cycle corresponds to the analog value.
37, 8	SS0, SS1	Serial interface I/O pin
36, 9	SCP0, SCP1	Serial interface clock pulse
23	RESET	Reset input for the initialization of the computer. Resets program counter, erases the status FFs. Sets all digital outputs to the H state (active H).
3	то	Input that can be tested with the conditional jump instructions JT0 and JNT0. The input contains a digital demodulator and can be used for the separation of the envelope curve from a modulated signal.
19	Т1	Input that can be tested with the conditional jump instructions JT1 and JNT1. Serves simultaneously as an external counter input. (Selection of functions with instruction STRT CNT). The input can also be used for zero passage recognition of low frequency alternating voltages.
18	ALE	This output generates one clock pulse signal per cycle.

# SDA 2010 instruction set

	Mnemonic	Description	Bytes	Cycles	Hexadecimal opcode
Accumulator	ADD A, Rr ADD A, @ R ADD A, # data ADDC A, @ R ADDC A, @ R ADDC A, # data ANL A, Rr ANL A, @ R ANL A, @ R ORL A, # data ORL A, # data XRL A, Rr XRL A, @ R XRL A, # data INC A DEC A CLR A CPL A DA A SWAP A RL C RR C	Add register to A Add data memory to A Add immediate to A Add register with carry Add data memory with carry Add immediate with carry Add immediate with carry And register to A And data memory to A And immediate to A Or register to A Or data memory to A Or immediate to A Exclusive Or register to A Exclusive Or data memory to A Exclusive Or immediate to A Increment A Decrement A Clear A Complement A Decimal adjust A Swap nibbles of A Rotate A left Rotate A right Rotate A right through carry	1 1 2 1 1 2 1 1 2 1 1 2 1 1 1 2 1 1 1 1	1 1 2 1 1 2 1 1 2 1 1 2 1 1 1 2 1 1 1 1	68-6F 60-61 03 78-7F 70-71 13 58-5F 50-51 53 48-4F 40-41 43 D8-DF D0-D1 D3 17 07 27 37 57 47 E7 F7

# SDA 2010 instruction set

ŀ	Mnemonic	Description	Bytes	Cycles	Hexadecimal opcode
0/1	IN A, Pp OUT Pp, A IN A, Sn OUT Sn, A	Input port to A Output A to port Input serial port to A0 Output A0 to serial port	1 1 1	2 2 2 2	08, 09, OC, OD 90, 39, 3C, 3D OE-OF 3E-3F
Registers	INC Rr INC @ R	Increment register Increment data memory	1	1 1	18–1F 10–11
Sub- routines	CALL	Jump to subroutine	1	2	14, 34, 54, 74, 94, B4, D4, F4,
Su routi	RET	Return	1	2	83
	JMP adr	Jump unconditional	2	2	04, 24, 44, 64, 84, A4, C4, E4
	JMPP@ A DJNZ Rr, adr	Jump indirect Decrement register and	1 2	2 2	B3 E8-EF
Branches	JC adr JNC adr JZ adr JNZ adr JT0 adr JNT0 adr JT1 adr JNT1 adr JTF adr	jump on R not zero Jump on carry = 1 Jump on carry = 0 Jump on A zero Jump on A not zero Jump on TO = 1 Jump on TO = 0 Jump on T1 = 1 Jump on T1 = 0 Jump on timer flag	2 2 2 2 2 2 2 2 2 2 2	2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	F6 E6 C6 96 36 26 56 46
Flags		Clear carry Complement carry	1 1	1	97 A7

# SDA 2010 instruction set

	Mnemonic	Description	Bytes	Cycles	Hexadecimal opcode
Transfer instructions	MOV A, Rr MOV A, @ R MOV A, #data MOV Rr, A MOV @ R, A MOV Rr #data MOV @ R, # data XCH A, Rr XCH A, @ R XCHD A, @ R	Move register to A Move data memory to A Move immediate to A Move A to register Move A to data memory Move immediate to register Move immediate to data memory Exchange A and register Exchange A and data memory Exchange nibble of A and register Move to A from current page	1 1 2 1 1 2 2 2 1 1 1 1	1 1 2 1 1 2 2 1 1 1 1 2	F8-FF F0-F1 23 A8-AF A0-A1 B8-BF B0-B1 28-2F 20-21 30-31 A3
Timer/Counter	MOV A, T MOV T, A STRT T STRT CNT STOP TCNT	Read timer/counter Load timer/counter Start timer Start counter Stop timer/counter	1 1 1 1	1 1 1 1	42 62 55 45 65
	MOV DA, A	Move A to DA – converter	1	2	91
	NOP	No operation	1	1	00

# Symbols and abbreviations

DA data	Accumulator 11-bit program memory address Event counter D/A converter 8-bit binary number	T T0, T1 #	Register label (r = 0-7) S interface label (n = 0; 1) Timer Test 0, Test 1 Refers to immediate data
	Mnemonic for "in page" operation		Refers to immediate data Refers to indirect addressing
L D	Port label $(n = 03)$		3